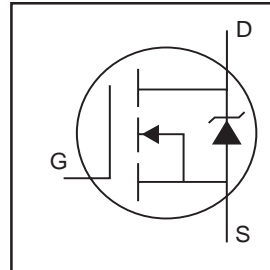


- Advanced Process Technology
- Dynamic dv/dt Rating
- 175 °C Operating Temperature
- Fast Switching
- Fully Avalanche Rated

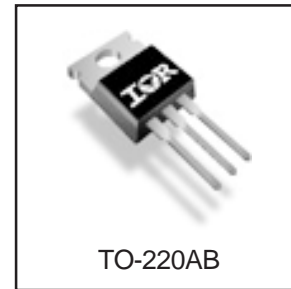


$V_{DSS} = 55V$
$R_{DS(on)} = 0.027\Omega$
$I_D = 41A\text{⑤}$

**Description**

Fifth Generation MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET® power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



**Absolute Maximum Ratings**

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	41⑤	A
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$	29⑤	
$I_{DM}$	Pulsed Drain Current ①	164	
$P_D @ T_C = 25^\circ C$	Power Dissipation	83	W
	Linear Derating Factor	0.56	W/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy②	190	mJ
$I_{AR}$	Avalanche Current①	25	A
$E_{AR}$	Repetitive Avalanche Energy①	8.3	mJ
dv/dt	Peak Diode Recovery dv/dt ③	5.0	V/ns
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

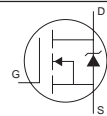
**Thermal Resistance**

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	1.8	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient	—	62	

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.05	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	0.027	$\Omega$	$V_{GS} = 10V, I_D = 25A$ ④⑥
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
$g_{fs}$	Forward Transconductance	13	—	—	S	$V_{DS} = 25V, I_D = 25A$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	25	$\mu A$	$V_{DS} = 55V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
$Q_g$	Total Gate Charge	—	—	50	nC	$I_D = 25A$
$Q_{gs}$	Gate-to-Source Charge	—	—	10		$V_{DS} = 44V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	21		$V_{GS} = 10V$ ④⑥
$t_{d(on)}$	Turn-On Delay Time	—	9.9	—	ns	$V_{DD} = 28V$
$t_r$	Rise Time	—	44	—		$I_D = 25A$
$t_{d(off)}$	Turn-Off Delay Time	—	34	—		$R_G = 9.1\Omega$
$t_f$	Fall Time	—	35	—		$R_D = 1.1\Omega$ ④ ⑥
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact ⑥ ⑥
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	1200	—	pF	$V_{GS} = 0V$
$C_{oss}$	Output Capacitance	—	390	—		$V_{DS} = 25V$
$C_{rss}$	Reverse Transfer Capacitance	—	140	—		$f = 1.0\text{MHz}$ ⑥

## Source-Drain Ratings and Characteristics

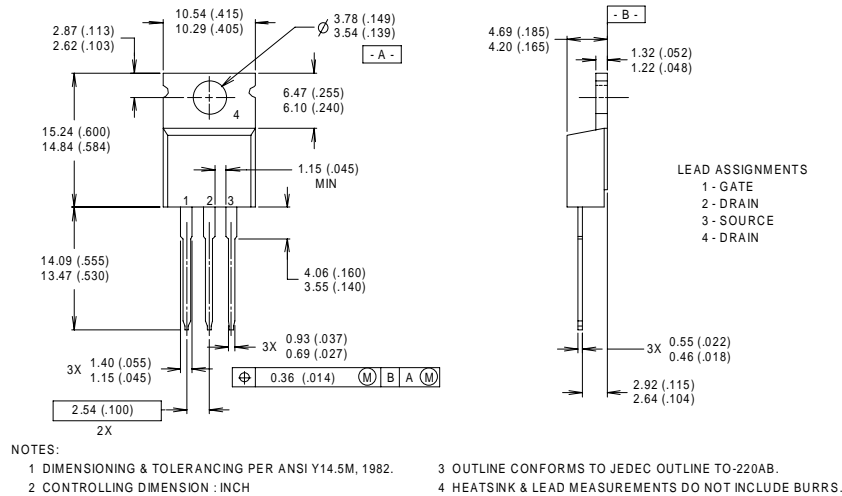
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	41 ⑤	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{SM}$	Pulsed Source Current (Body Diode) ①⑥	—	—	164		
$V_{SD}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 25A, V_{GS} = 0V$ ④⑥
$t_{rr}$	Reverse Recovery Time	—	63	94	ns	$T_J = 25^\circ\text{C}, I_F = 25A$
$Q_{rr}$	Reverse Recovery Charge	—	140	210	nC	$di/dt = 100A/\mu s$ ④ ⑥
$t_{on}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )				

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ②  $V_{DD} = 25V$ , Starting  $T_J = 25^\circ\text{C}$ ,  $L = 610\mu H$ ,  $R_G = 25\Omega$ ,  $I_{AS} = 25A$
- ③  $I_{SD} \leq 25A$ ,  $di/dt \leq 220A/\mu s$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu s$ ; duty cycle  $\leq 2\%$
- ⑤ Calculated continuous current based on maximum allowable junction temperature: Package limitation current = 20A
- ⑥ Use IRFR/U1205 Data and Test conditons.

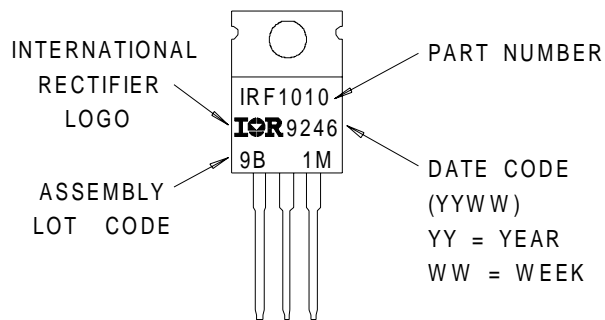
## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



## TO-220AB Part Marking Information

EXAMPLE : THIS IS AN IRF1010  
WITH ASSEMBLY  
LOT CODE 9B1M



International  
**IR** Rectifier

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*Data and specifications subject to change without notice. 11/99*